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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/944,426	08/30/2001	Vladislav Vashchenko	75292/13356 1844	
75	90 01/07/2005		EXAM	INER
Jurgen K Vollrath			NADAV, ORI	
588 Sutter Street #531 San Francisco, CA 94102			ART UNIT	PAPER NUMBER
			2811	
			DATE MAILED: 01/07/2005	

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)			
		09/944,426	VASHCHENKO, VLADISLAV			
	Office Action Summary	Examiner	Art Unit			
		ori nadav	2811			
Period fo	- The MAILING DATE of this communication apport	pears on the cover sheet with the	correspondence address			
A SH THE - Exte after - If the - If NO - Failt Any	MAILING DATE OF THIS COMMUNICATION.  Insions of time may be available under the provisions of 37 CFR 1.15  SIX (6) MONTHS from the mailing date of this communication.  In period for reply specified above is less than thirty (30) days, a reply operiod for reply is specified above, the maximum statutory period ware to reply within the set or extended period for reply will, by statute reply received by the Office later than three months after the mailing and patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be tily within the statutory minimum of thirty (30) days apply and will expire SIX (6) MONTHS from a cause the application to become ABANDONE	mely filed ys will be considered timely. In the mailing date of this communication. ED (35 U.S.C. § 133).			
Status						
1)[🖂	Responsive to communication(s) filed on 06 D	ecember 2004.				
2a)□	•	action is non-final.				
3)□	Since this application is in condition for allowance except for formal matters, prosecution as to the ments is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.					
Disposit	ion of Claims					
5)□ 6)⊠ 7)□	Claim(s) <u>1-4 and 6</u> is/are pending in the applicate 4a) Of the above claim(s) <u>1</u> is/are withdrawn from Claim(s) is/are allowed.  Claim(s) <u>2-4 and 6</u> is/are rejected.  Claim(s) is/are objected to.  Claim(s) are subject to restriction and/or	om consideration.				
Applicat	ion Papers					
9)[]	The specification is objected to by the Examine	er.				
,—	10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.					
,	Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).					
11)□	Replacement drawing sheet(s) including the correct The oath or declaration is objected to by the Ex					
•	under 35 U.S.C. § 119		·			
12) [ a)	Acknowledgment is made of a claim for foreign All b) Some * c) None of:  1. Certified copies of the priority document 2. Certified copies of the priority document 3. Copies of the certified copies of the priority document application from the International Bureau See the attached detailed Office action for a list	s have been received. s have been received in Applications rity documents have been received in the contract of the contract o	tion No red in this National Stage			
Attachmer	ıt(s)					
1) Notic	ce of References Cited (PTO-892)	4) Interview Summar				
3) Infor	ce of Draftsperson's Patent Drawing Review (PTO-948) mation Disclosure Statement(s) (PTO-1449 or PTO/SB/08) or No(s)/Mail Date	Paper No(s)/Mail D 5) Notice of Informal 6) Other:	Patent Application (PTO-152)			

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#### **DETAILED ACTION**

#### Claim Objections

Claim 2 is objected to because of the following informalities: The phrase "a n+ region" in line 3 should read "an n+ region".

Appropriate correction is required.

### Claim Rejections - 35 USC § 112

The following is a quotation of the first paragraph of 35 U.S.C. 112:

The specification shall contain a written description of the invention, and of the manner and process of making and using it, in such full, clear, concise, and exact terms as to enable any person skilled in the art to which it pertains, or with which it is most nearly connected, to make and use the same and shall set forth the best mode contemplated by the inventor of carrying out his invention.

Claims 2-4 and 6 are rejected under 35 U.S.C. 112, first paragraph, as failing to comply with the written description requirement. The claim(s) contains subject matter which was not described in the specification in such a way as to reasonably convey to one skilled in the relevant art that the inventor(s), at the time the application was filed, had possession of the claimed invention. There is no support for the claimed limitations of forming at least one p+ region and at least one additional n+ region to define at least one p-n junction between the at least one p+ region and the at least one additional n+ region in the p well are separated by an isolation region.

There is no support in the disclosure for the claimed limitations of at least one highly doped n+ region and at least one highly doped p+ region formed in the p-material of the p-well being forward biased relative to each other during normal operation, as recited in claim 3.

## Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

Claims 2-4 and 6 are rejected under 35 U.S.C. 102(e) as being anticipated by Ker et al. (6,465,848).

Regarding claim 2, Ker et al. teach in figure 3a and related text a method of increasing the holding voltage of a LVTSCR structure that includes an n-well 42 and a p-well 44 formed in a substrate 40, an n+ region 46 and a p+ region 48 formed in the n-well 42, and an n+ region 54 formed in the p-well 44, the method comprising forming at least one p+ region 58 and at least one additional n+ region 60 inside the p-well 44 of the structure to define at least one p-n junction between the at least one p+ region 58 and

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the at least one additional n+ region in the p well that is forward biased during normal

operation.

Regarding claims 3-4 and 6, Ker et al. teach in figure 3a and related text a method of increasing the holding voltage of a LVTSCR structure having an anode in an n-well 42 and a cathode in a p- well 44, comprising providing an alternative current path from anode to cathode through the p-well of the structure, other than purely the current path from anode to cathode through at least one highly doped n+ region and at least one highly doped p+ region formed in the p-material of the p-well, the at least one highly doped n+ region and at least one highly doped p+ region formed in the p-material of the p-well being forward biased relative to each other during normal operation, wherein the alternative current path defines a lower resistance current path than the p-well, and wherein at least one diode is formed in the p-well which provides a low resistance current path through the at least one diode once the threshold voltage across the at least one diode is exceeded.

## Response to Arguments

Applicant argues that Ker does not teach at least one highly doped n+ region and at least one highly doped p+ region formed in the p-well are forward biased, because the n+ region and the p+ region of Ker et al.'s device are connected to a common contact.

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There is no support in the disclosure for the claimed limitations of at least one highly doped n+ region and at least one highly doped p+ region formed in the p-material of the p-well being forward biased relative to each other during normal operation, as recited in claim 3. Furthermore, Ker et al. teach in figure 3a and related text a current path in the direction from the anode to the n+ region in the p-well. Therefore, the n+ region and the p+ region formed in the p-well are forward biased, as claimed.

Papers related to this application may be submitted to Technology center (TC) 2800 by facsimile transmission. Papers should be faxed to TC 2800 via the TC 2800 Fax center located in Crystal Plaza 4, room 4-C23. The faxing of such papers must conform with the notice published in the Official Gazette, 1096 OG 30 (November 15, 1989). The Group 2811 Fax Center number is (703) 308-7722 and 308-7724. The Group 2811 Fax Center is to be used only for papers related to Group 2811 applications.

Any inquiry concerning this communication or any earlier communication from the Examiner should be directed to *Examiner Nadav* whose telephone number is **(571) 272-1660**. The Examiner is in the Office generally between the hours of 7 AM to 4 PM (Eastern Standard Time) Monday through Friday.

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Any inquiry of a general nature or relating to the status of this application should be directed to the **Technology Center Receptionists** whose telephone number is **308-0956**.

O.N. January 3, 2005 ORI NADAV
PRIMARY EXAMINER
TECHNOLOGY CENTER 2800